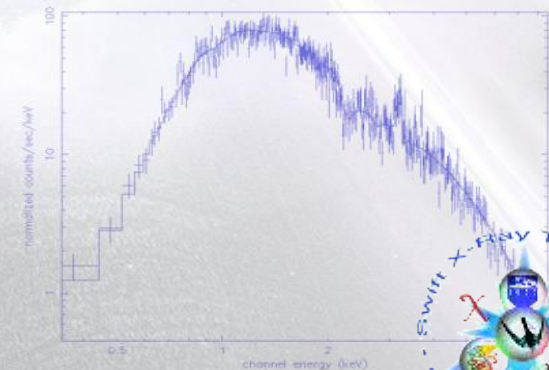
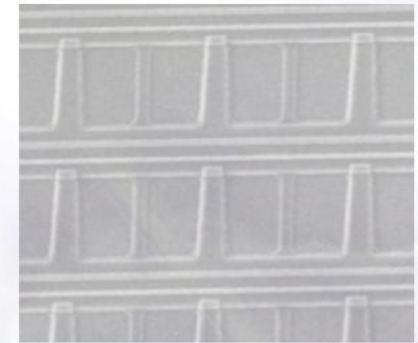
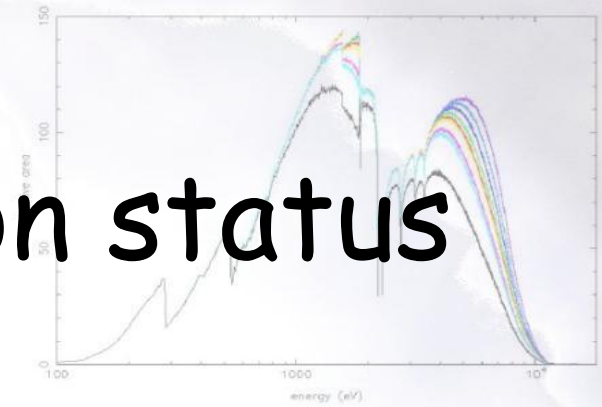


# *Swift*-XRT calibration status update

**Andy Beardmore**  
on behalf of the  
*Swift*-XRT team



## Changes since IACHEC 2007

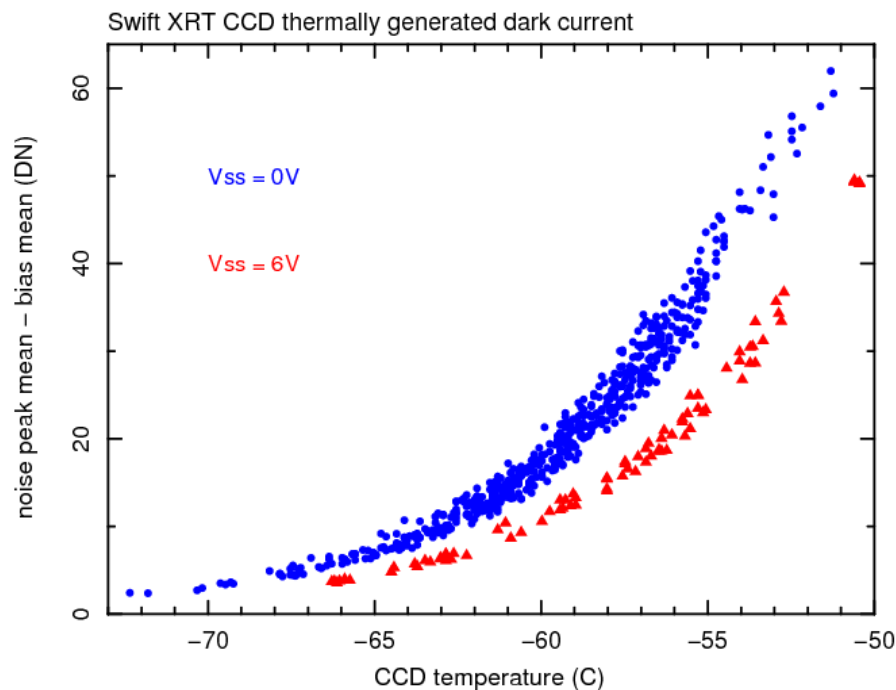
- CCD Substrate Voltage Change : 0V→6V (2008/08/30)
- Improved on-board temperature dependent event threshold tables (2007/09/14)
  - Reduces dark current, allowing the CCD to operate at higher T before pixels become `hot`
- On-board flight s/w efficiency enhancements (2008/06) → continuous Fe-55 cal source data
  - CTI estimate improvements
- Charge Trap mapping using Cas A
- Broadened RMFs



- XRT CCD operates at temperatures from  $-75^{\circ}\text{C}$  to  $-48^{\circ}\text{C}$  (ideally  $-50^{\circ}\text{C}$ ) because of a failure of the TEC shortly after launch.
- In 2005, a lab programme (led by Tony Abbey at LU) showed that by raising the substrate voltage the noise performance properties of a flight spare CCD operating at high T were improved.
  - Tests suggested  $\text{SSV} = 6\text{V}$  would be optimal

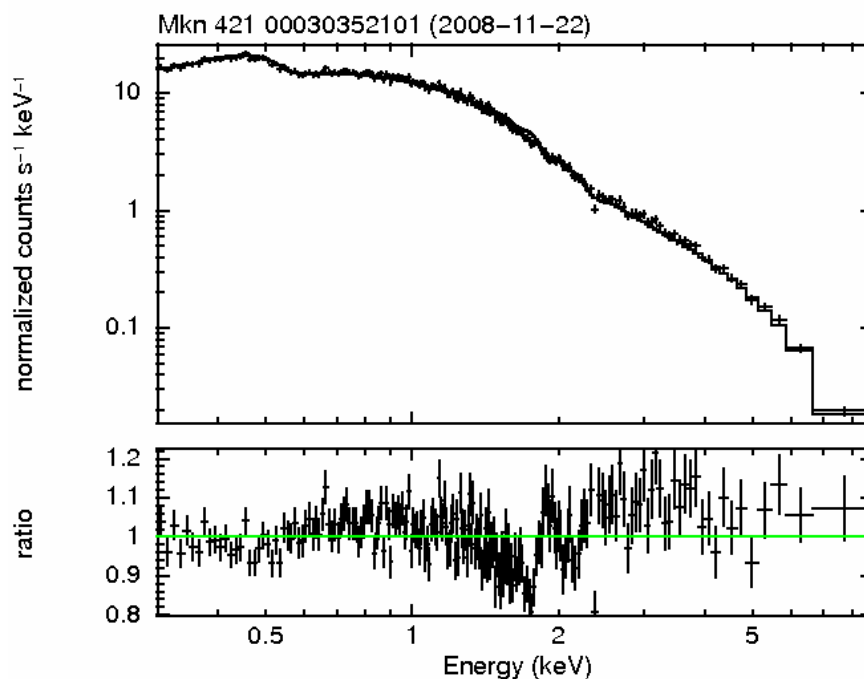


- Substrate voltage changed to 6V on 2007/08/30
- Raw-frame analysis



- Around same time (2007/09/14), Jamie uploaded new temperature dependent event threshold tables
  - Significant reduction in the on-board count rate → less hot pixels and mode switching when CCD is warmed up to  $-50C$ .

- Downside - 10% QE changes at high energies (above 5 keV) and around the Si K-edge

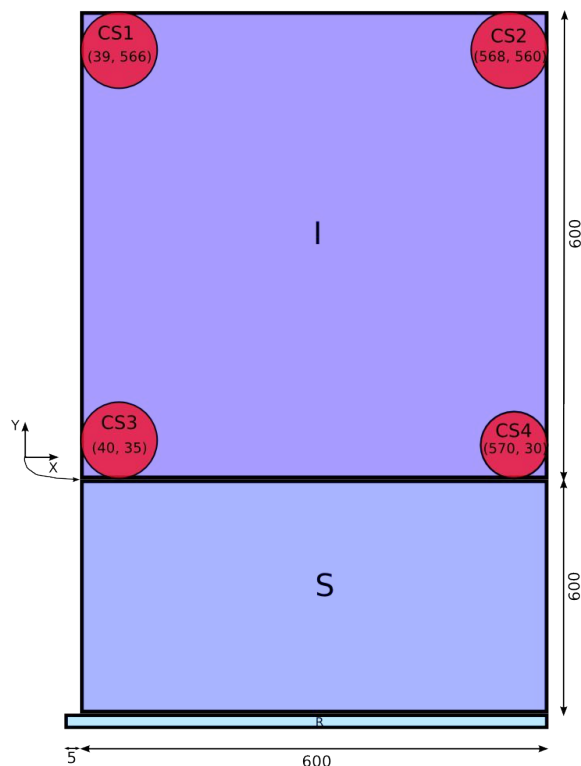


- To be fixed in next release of RMF/ARF
- Also different operating voltages caused a gain change



- In 2008-June, flight software improvements were uploaded which allowed the CCD to be read out more efficiently.
- This meant continuous collection of full-frame CCD data, which includes Fe-55 "corner sources" used for gain/CTI estimates.
- Prior to this we were limited to a few frames of data near midnight (part of `Daily Ops proc`)





cs1 to cs4 : Fe-55 corner sources

Measured PHA value (DN) :

$$D = \frac{E}{A} (1 - CTI_{p,i})^Y (1 - CTI_{p,f})^{Y_S} (1 - CTI_s)^{(X+5)}$$

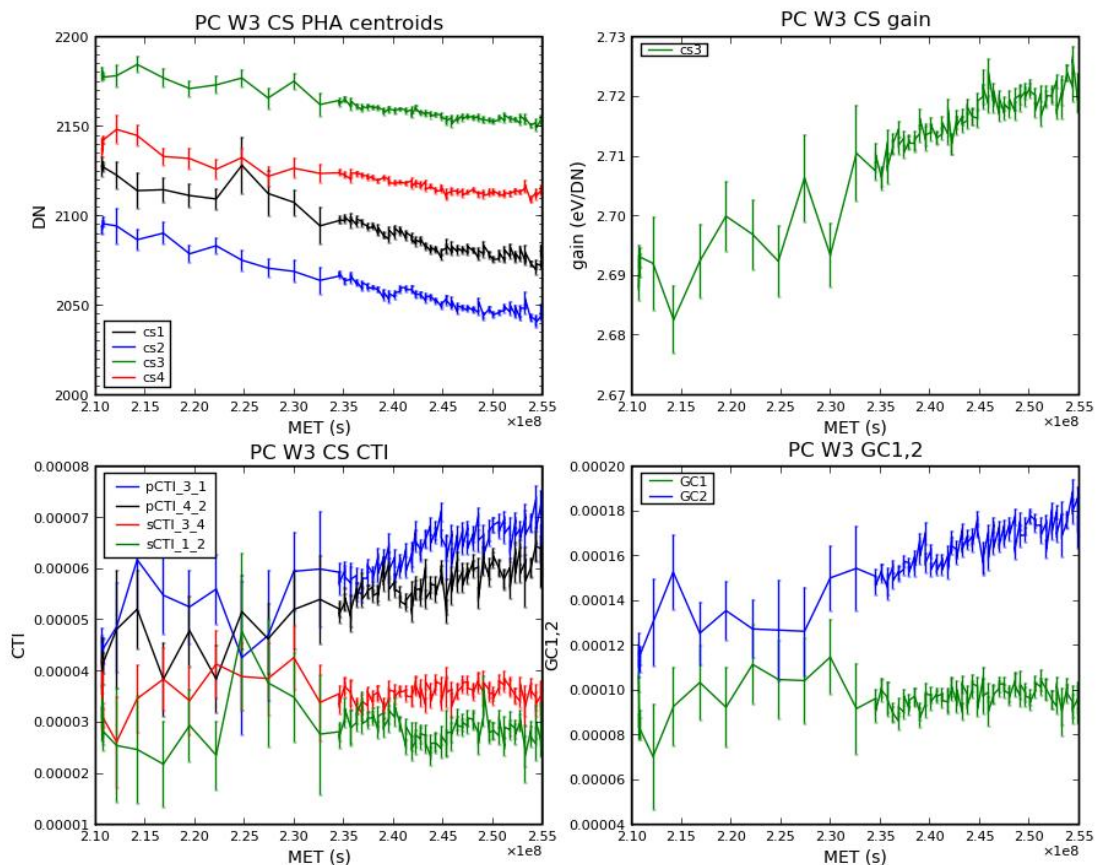
cs3 → gain coefficient evolves with time

cs3-cs4 → serial CTI

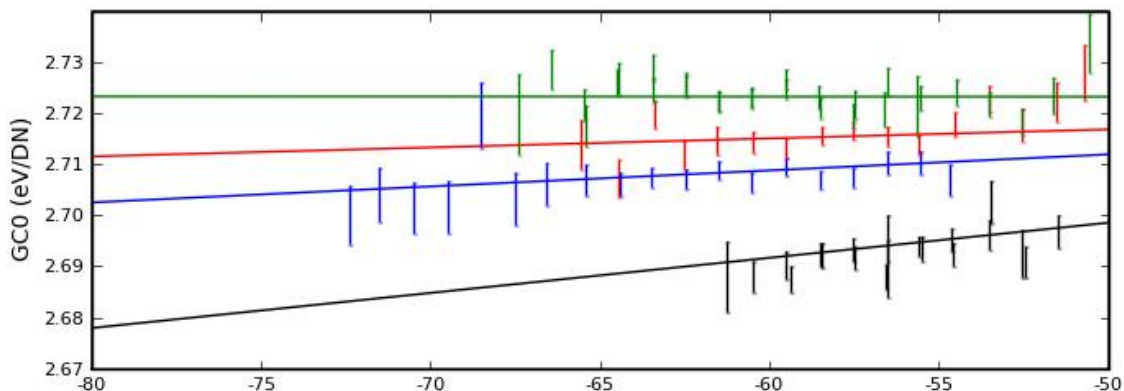
cs3-cs1 & cs4-cs2 → parallel CTI



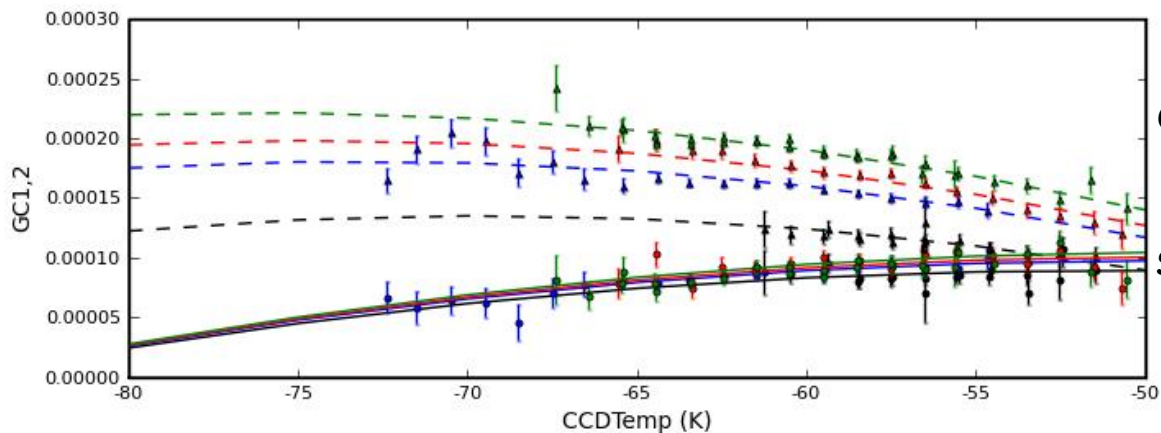
- Corner source data from 2007-09 to 2009-01 at -57C



Gain



CTI

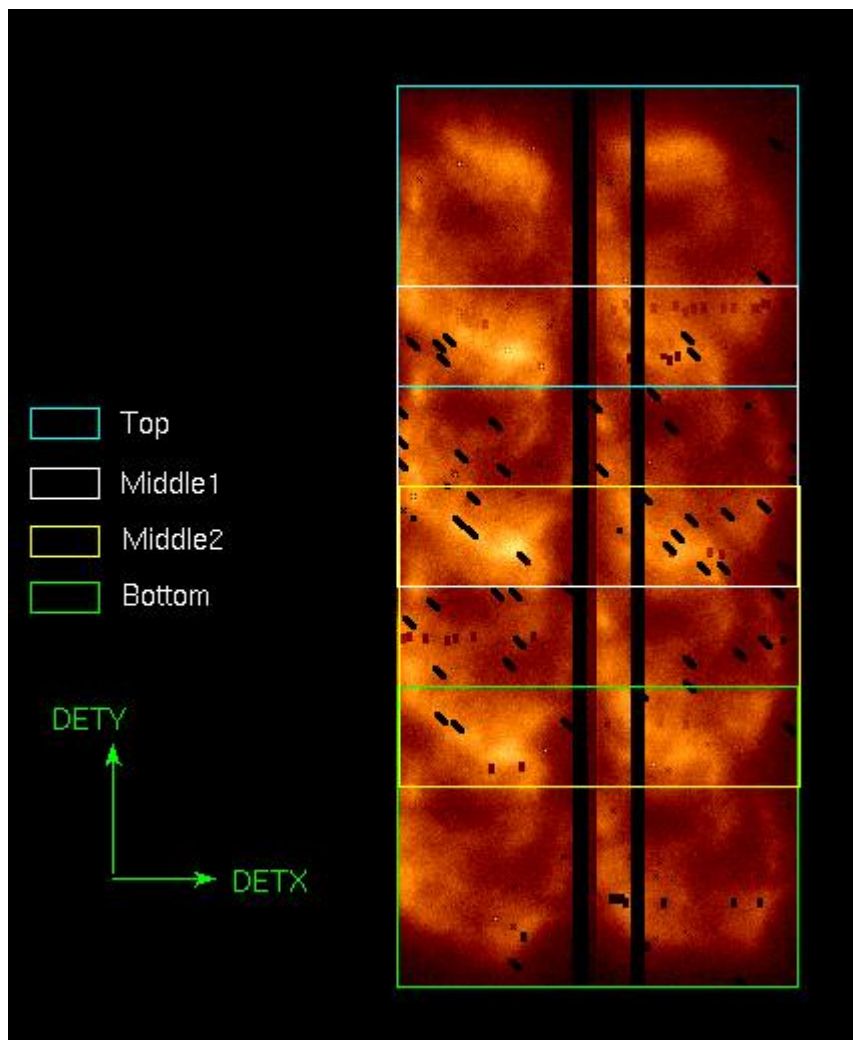


- Much improved characterisation of the XRT photon counting mode gain / CTI behaviour as a function of time and temperature
- Difficult to get an accurate estimate of the CTI energy dependence:  $CTI(E) \sim E^{-0.5}$
- No direct measure of gain/CTI in windowed timing mode (1.8 ms readout mode).
  - Cas A offset observations hint CTI is worse in WT mode
- Started theoretical modelling of the gain/CTI using code developed by Ian Hutchinson (LU)

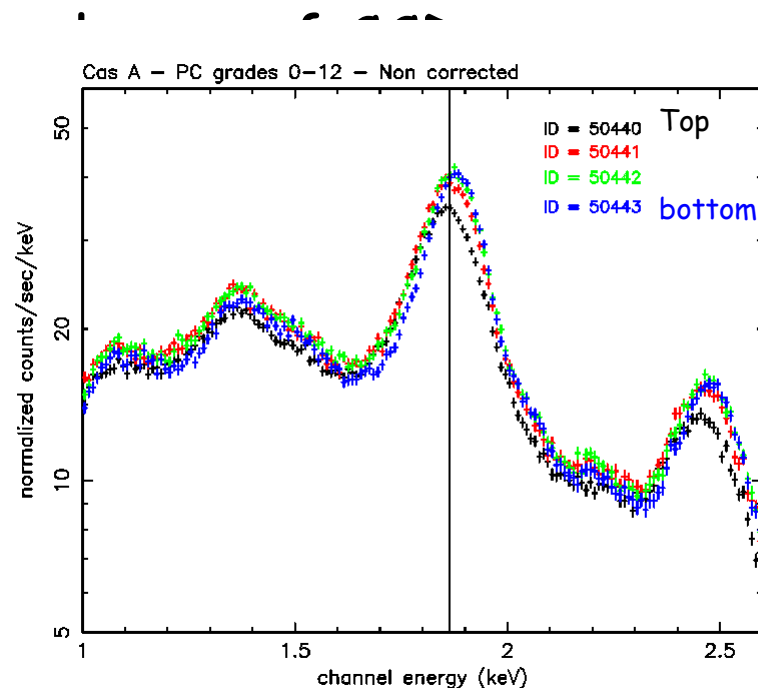


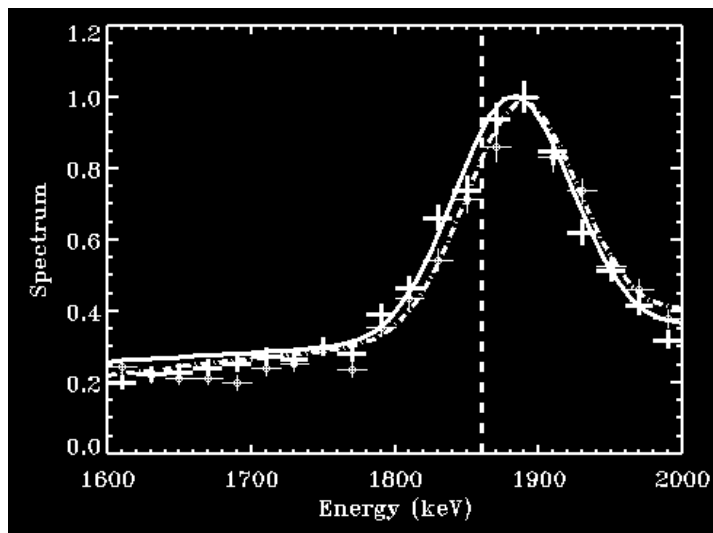
- Significant charge traps have been developing on CCD for some time
- No fully-illuminated CCD calibration data to investigate traps with
- While charge injection is possible on CCD22, it can't be controlled accurately enough.
  - Column-column variations
- What can we do?
  - Cas A...



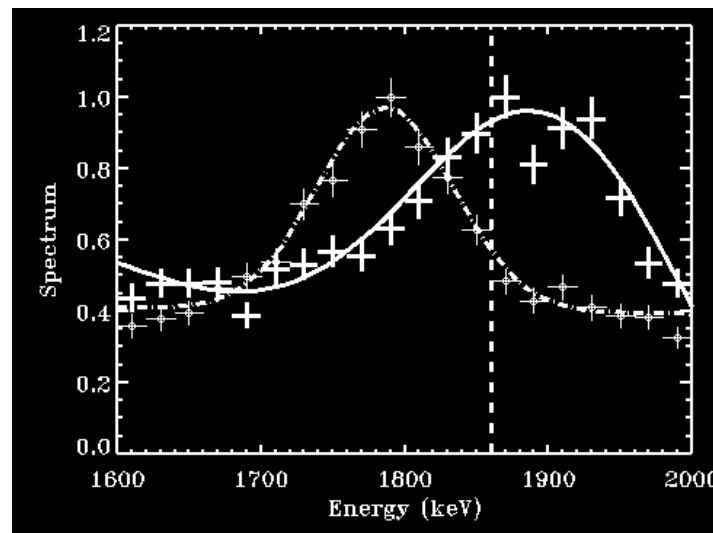


129 ks of data taken in  
8 offset pointings  
covering the central 200





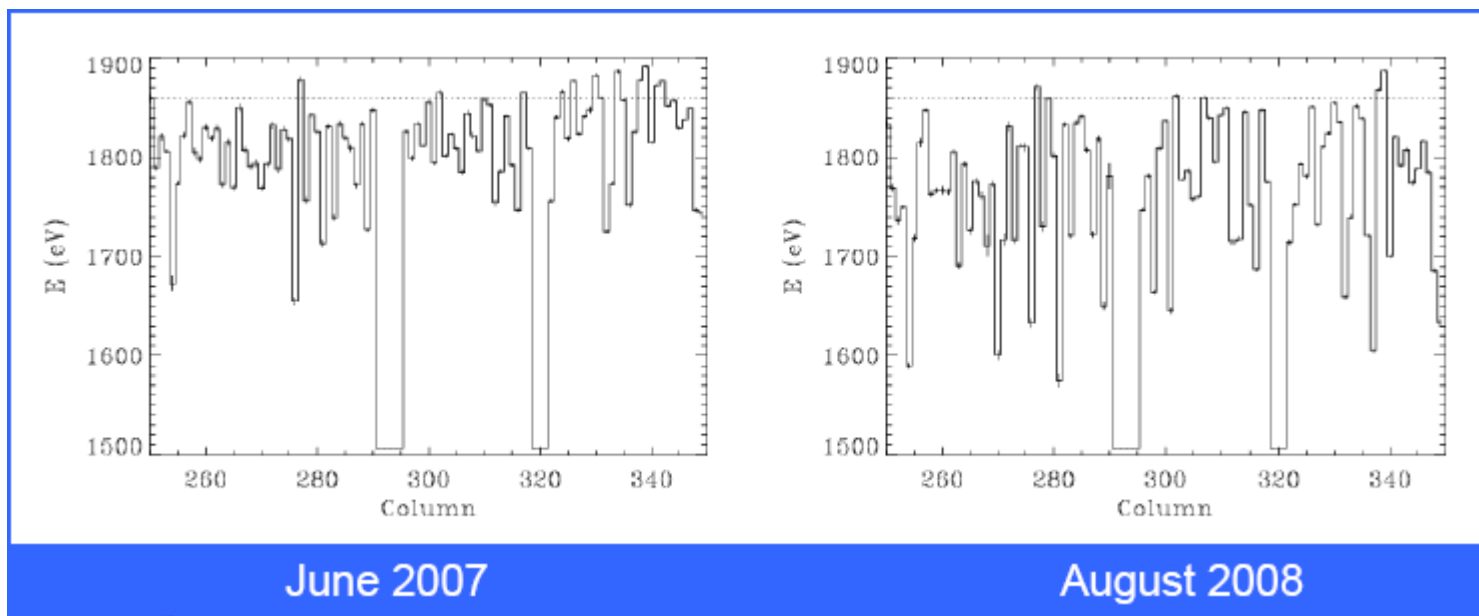
Column 202: no trap

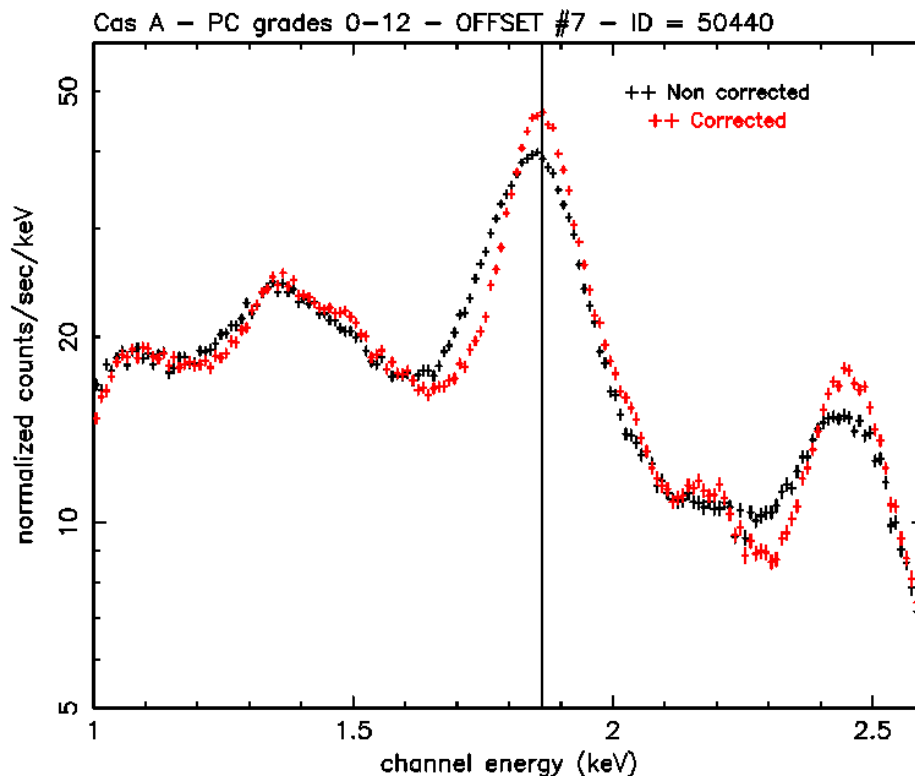


Column 343: trap  $\sim 100$  eV

- Using an "iterative" process can refine the trap location to  $\sim 20$ - $30$  pixels in DETY
- Spectral variation across the remnant limits minimum trap depth to  $\sim 20$  eV

- Mean column-by-column Si- Kalpha centroid

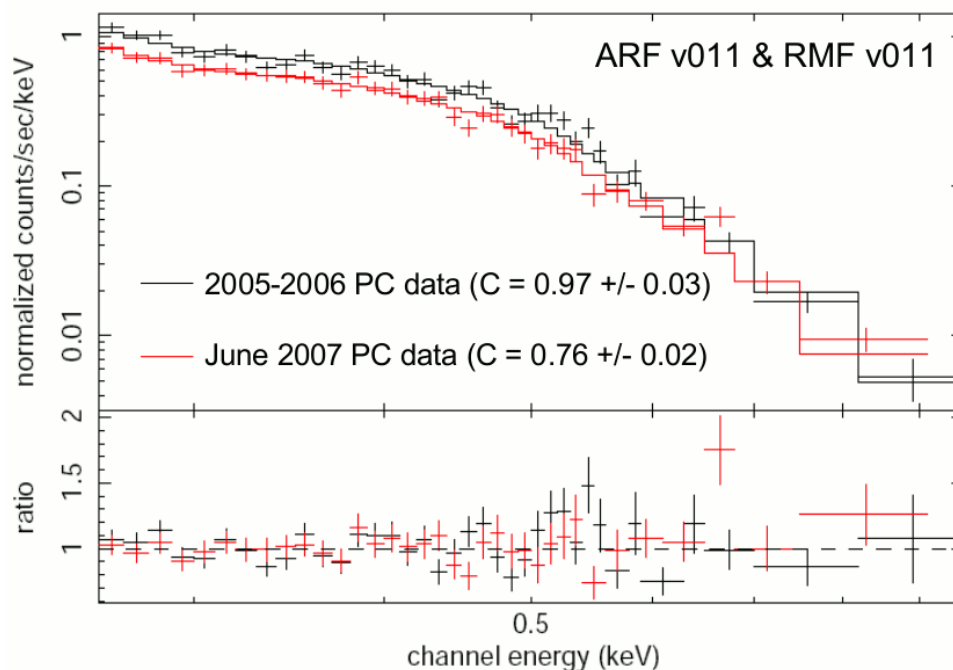




- Significant improvement in the FWHM
- New ground s/w under development to perform the trap correction
- Need to take cal data every ~6 months to monitor traps

- Worsening CTE is increasing the response kernel FWHM
- Trap build up is also responsible for reducing QE at low E as good events are lost below threshold

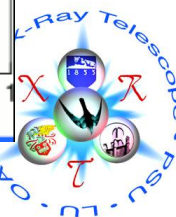
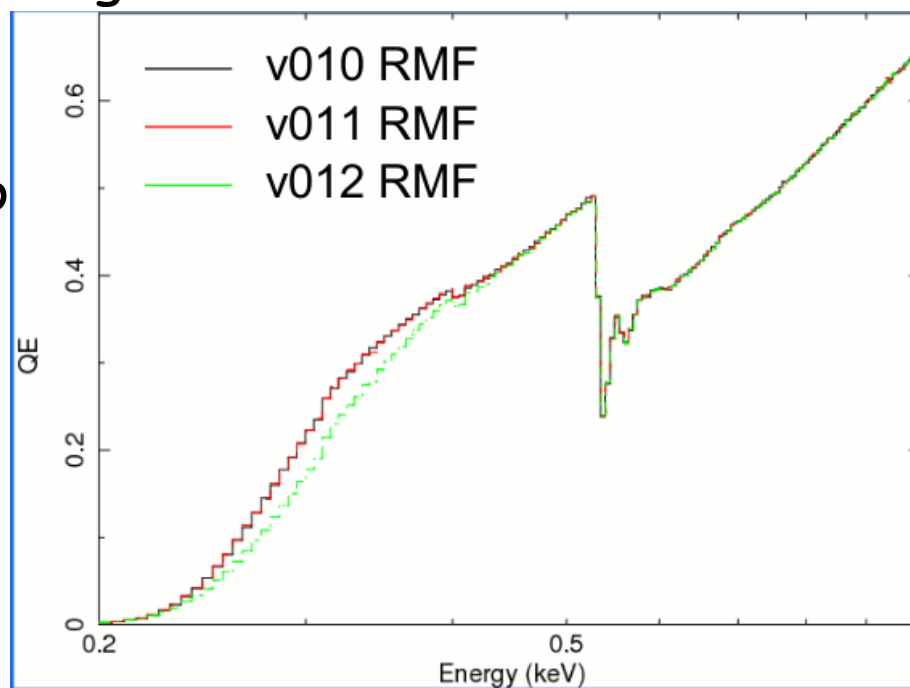
RXJ1856



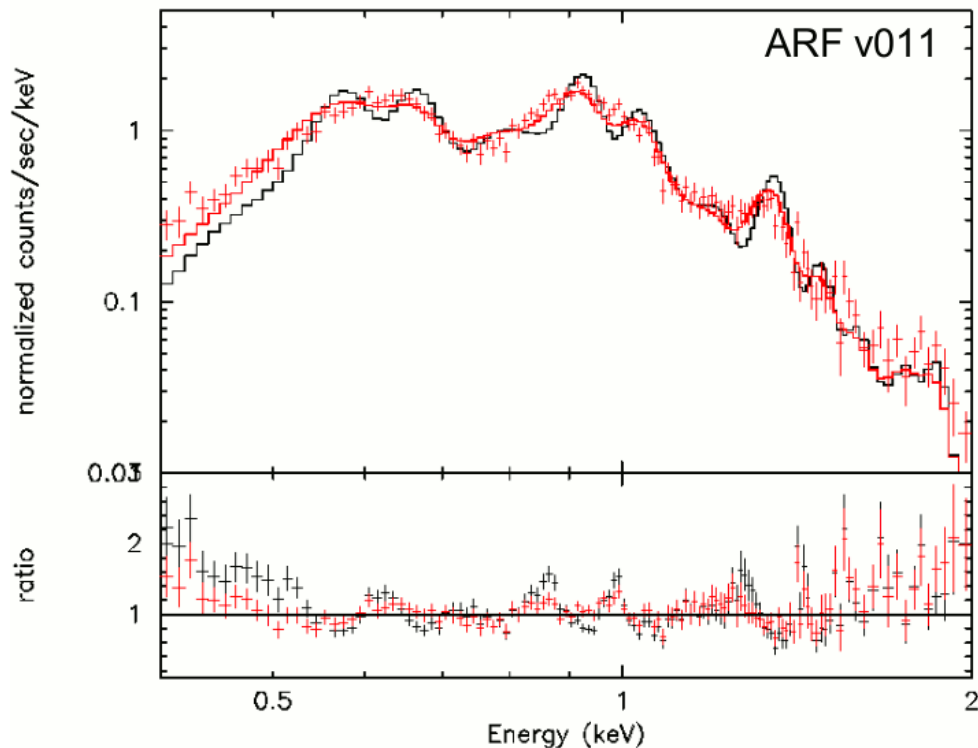
Burwitz et al  
bbody model



- Olivier Godet developed a RMF kernel convolution function (2 gaussians) with CTI dependent FWHM
- Carefully tuned on line source E0102, and on continuum sources below the O - edge
- Reduces QE at low E
- Account for RXJ1856



black: v011 WT g0-2 RMF; red: new broadened WT g0-2 RMF



E0102 with IACHEC  
model

broadened RMF in RED

- Fixed epoch RMFs released for data from 2007-03 (pre-SSV) and 2007-09 (post-SSV) for WT mode. PC to follow
- ToDo - need a s/w tool to automatically compute the broadening

